

LIST OF REFERENCES CITED BY APPLICANT

FEB 21 2003

Attn Docket No.: 3397-84PUS

Filing Date: December 03, 1999

Serial No.: 09/445,004

Group Art: 3721

Applicant: Risto FORSSTROM et al.

U.S. PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Name	Class	Subclass	Filing Date
	AA	4,914,891	04/1990	Suolahti	53	399	05/1988
	AB	4,003,527	01/1977	Schulze	242	58	10/1975
	AC						
	AD						
	AE						

FOREIGN PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
	AF	GB 2 197 842 A	06/1988	United Kingdom	Lappalainen et al.	B65B	11/04	Yes
	AG	SE 503 181	5/1988	Sweden	Lappalainen et al.	B65B	25/14	Yes, See GB 1 197 842 A
	AH							
	AI							
	AJ							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

AK		
AL		
AM		

EXAMINER: J. LandDATE CONSIDERED: 5/17/03

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Serial No.: Group Art:
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U.S. PATENT DOCUMENTS

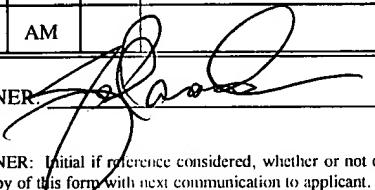
*Ex. Intls		Document No.	Date	Name	Class	Subclass	Filing Date
	AA	4,003,527	01-18-77	Schulze	—	—	10-01-75
	AB	5,642,600	07-01-97	Hooper et al.	—	—	04-05-96
	AC	4,914,891	04-10-90	Suolahti	—	—	05-26-88
	AD						
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FOREIGN PATENT DOCUMENTS

*Ex. Intls		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
	AF	503 181 C2	04-15-96	Sweden	Lappalainen et al.	—	—	No
	AG							
	AH							
	AI							
	AJ							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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